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Atmel

ATA6612C/ATA6613C

8K/16K Flash Microcontroller with LIN Transceiver, 5V Regulator and Watchdog

DATASHEET

General Features

- Single-package fully-integrated Atmel[®] AVR[®] 8-bit microcontroller with LIN transceiver, 5V regulator (85mA current capability) and watchdog
- Very low current consumption in sleep mode
- 8Kbytes/16Kbytes flash memory for application program (Atmel ATA6612C/ATA6613C)
- Supply voltage up to 40V
- Operating voltage: 5V to 27V
- Temperature range: T_{case} –40°C to +125°C
- QFN48, 7mm × 7mm package

Description

Atmel ATA6612C/ATA6613C is a system-in-package (SiP) product, which is particularly suited for complete LIN-bus slave-node applications. I consists of two ICs in one package supporting highly integrated solutions for in-vehicle LIN networks. The first chip is the LIN-system-basis-chip (LIN-SBC) Atmel ATA6624, which has an integrated LIN transceiver, a 5V regulator and a window watchdog. The second chip is an automotive microcontroller from Atmel series of Atmel AVR 8-bit microcontroller with advanced RISC architecture.

The Atmel ATA6612C consists of the LIN-SBC Atmel ATA6624 and the Atmel ATmega88 with 8Kbytes flash. The Atmel ATA6613C consists of the LIN-SBC Atmel ATA6624 and the Atmel ATmega168 with 16Kbytes flash. All pins of the LIN system basis chip as well as all pins of the Atmel AVR microcontroller are bonded out to provide customers the same flexibility for their applications as they have when using discrete parts.

In section 2 you will find the pin configuration for the complete SiP. In sections 3 to 5 the LIN SBC is described, and in sections 6 to 7 the Atmel AVR is described in detail.

Figure 1. Application Diagram

Atmel ATA6612C/ATA	6613C	 LIN	Bus
MCU Atmel ATmega88 or ATmega168	LIN-SBC Atmel ATA6624		•



1. Pin Configuration

Figure 1-1.	Pinning QFN48	8, 7mm $ imes$ 7mm
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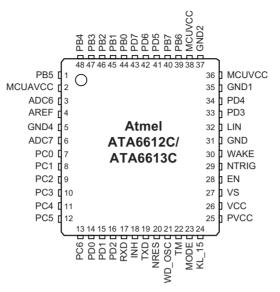


Table 1-1. Pin Description

Pin	Symbol	Function
1	PB5	Port B 5 I/O line (SCK / PCINT5)
2	MCUAVCC	Microcontroller ADC-unit supply voltage (referred to as AVCC pin in Section 5. "Microcontroller Block" on page 27 and Section 6. "2-wire Serial Interface Characteristics" on page 276)
3	ADC6	ADC input channel 6
4	AREF	Analog reference voltage input
5	GND4	Ground
6	ADC7	ADC input channel 7
7	PC0	Port C 0 I/O line (ADC0/PCINT8)
8	PC1	Port C 1 I/O line (ADC1/PCINT9)
9	PC2	Port C 2 I/O line (ADC2/PCINT10)
10	PC3	Port C 3 I/O line (ADC3/PCINT11)
11	PC4	Port C 4 I/O line (ADC4/SDA/PCINT12)
12	PC5	Port C 5 I/O line (ADC5/SCL/PCINT13)
13	PC6	Port C 6 I/O line (RESET/PCINT14)
14	PD0	Port D 0 I/O line (RXD/PCINT16)
15	PD1	Port D 1 I/O line (TXD/PCINT17)
16	PD2	Port D 2 I/O line (INT0/PCINT18)
17 ⁽¹⁾	RXD	Receive data output
18 ⁽¹⁾	INH	High side switch output for controlling an external voltage regulator
19 ⁽¹⁾	TXD	Transmit data input / active low output after a local wake up request
Note: 1.	This identifie	es the pins of the LIN SBC Atmel ATA6624

Table 1-1. Pin Description (Continued)

Pin	Symbol	Function
20 ⁽¹⁾	NRES	Watchdog and under voltage reset output (open drain)
21 ⁽¹⁾	WD_OSC	External resistor for adjustable watchdog timing
22 ⁽¹⁾	TM	Tie to ground – for factory use only
23 ⁽¹⁾	MODE	Connect to GND for normal watchdog operation or connect to VCC for debug mode
24 ⁽¹⁾	KL_15	Ignition detection (edge sensitive)
25 ⁽¹⁾	PVCC	Voltage regulator sense input
26 ⁽¹⁾	VCC	Voltage regulator output
27 ⁽¹⁾	VS	Battery connection
28 ⁽¹⁾	EN	LIN-transceiver enable input
29 ⁽¹⁾	NTRIG	Watchdog trigger input (negative edge)
30 ⁽¹⁾	WAKE	System-basis-chip external wake-up input
31 ⁽¹⁾	GND	Analog system GND
32 ⁽¹⁾	LIN	LIN-bus input/output
33	PD3	Port D 3 I/O line (INT1 OC2B/PCINT19)
34	PD4	Port D 4 I/O line (T0/XCK/PCINT20)
35	GND1	Ground
36	MCUVCC	Microcontroller supply voltage (referred to as VCC pin in Section 5. "Microcontroller Block" on page 27 and Section 6. "2-wire Serial Interface Characteristics" on page 276)
37	GND2	Ground
38	MCUVCC	Microcontroller supply voltage (referred to as VCC pin in Section 5. "Microcontroller Block" on page 27 and Section 6. "2-wire Serial Interface Characteristics" on page 276)
39	PB6	Port B 6 I/O line (TOSC1/XTAL1/PCINT6)
40	PB7	Port B 7 I/O line (TOSC2/XTAL2/PCINT7)
41	PD5	Port D 5 I/O line (T1/OC0B/PCINT21)
42	PD6	Port D 6 I/O line (AIN0/OC0A PCINT22)
43	PD7	Port D 7 I/O line (AIN1/PCINT23)
44	PB0	Port B 0 I/O line (ICP1/CLKO/PCINT0)
45	PB1	Port B 1 I/O line (OC1A/PCINT1)
46	PB2	Port B 2 I/O line (OC1B/SS/PCINT2)
47	PB3	Port B 3 I/O line (MOSI/OC2A/PCINT3)
48	PB4	Port B 4 I/O line (MISO/PCINT4)
Backside		Heat slug is connected to GND
Note: 1.	This identifi	es the pins of the LIN SBC Atmel ATA6624



2. Absolute Maximum Ratings

Table 2-1. Maximum Ratings of the SiP

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Min.	Тур.	Max.	Unit
HBM ESD ANSI/ESD -STM5.1 JESD22 -A114 AEC-Q100 (002)		±2			KV
CDM ESD STM 5.3.1 Corner pins (1, 12, 13, 24, 25, 36, 37, 48) All other pins		750 500			V V
Machine model ESD AEC-Q100-Rev.F (003)		±100			V
ESD according to IBEE LIN EMC Test Spec. 1.0 following IEC 61000-4-2 - Pin VS, LIN, KL_15 (47k Ω /100nF) to GND - Pin WAKE (33 k Ω serial resistor) to GND		±6 ±5			KV KV
ESD HBM following STM5.1 with 1.5k Ω 100pF - Pin VS, LIN, KL_15, WAKE to GND		±6			KV
Storage temperature	Τ _s	-55		+150	°C
Operating temperature ⁽¹⁾	T _{case}	-40		+125	°C
Thermal resistance junction to heat slug	R _{thjc}		5		K/W
Thermal resistance junctiion to ambient	R _{thja}		25		K/W
Thermal shutdown of VCC regulator		150	165	170	°C
Thermal shutdown of LIN output		150	165	170	°C
Thermal shutdown hysteresis			10		°C

Note: 1. T_{case} means the temperature of the heat slug (backside). It is mandatory that this backside temperature is $\leq 125^{\circ}$ C in the application.

Table 2-2. Maximum Ratings of the LIN-SBC

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Min.	Тур.	Max.	Unit
Supply voltage V _S	Vs	-0.3		+40	V
Pulse time \leq 500ms; T _a = 25°C Output current I _{VCC} \leq 85mA	Vs			+40	V
Pulse time ≤ 2 min; T _a = 25°C Output current I _{VCC} ≤ 85 mA	Vs			27	V
WAKE (with $33k\Omega$ serial resistor) KL_15 (with $47k\Omega/100nF$) DC voltage Transient voltage due to ISO7637 (coupling 1nF)		-1 -150		+40 +100	V V
INH - DC voltage		-0.3		V _S + 0.3	V
LIN - DC voltage		-27		+40	V
Logic pins (RxD, TxD, EN, NRES, NTRIG, WD_OSC, MODE, TM)		-0.3		+5.5	V
Output current NRES	I _{NRES}			+2	mA
PVCC DC voltage VCC DC voltage		-0.3 -0.3		+5.5 +6.5	V V

Table 2-3. Maximum Ratings of the Microcontroller

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Min.	Тур.	Max.	Unit
Voltage on any pin except RESET with respect to ground		-0.5		MCUVCC + 0.5	V
Voltage on RESET with respect to ground		-0.5		13.0	V
Maximum operating voltage				6.0	V
DC current per I/O pin				40.0	mA
DC current MCUVCC and GND pins				200.0	mA
Injection current at MCUVCC = 0V ⁽¹⁾				±5.0	mA
Injection current at MCUVCC = 5V				±1.0	mA

Note: 1. Maximum current per port = ± 30 mA



3. LIN System-basis-chip Block

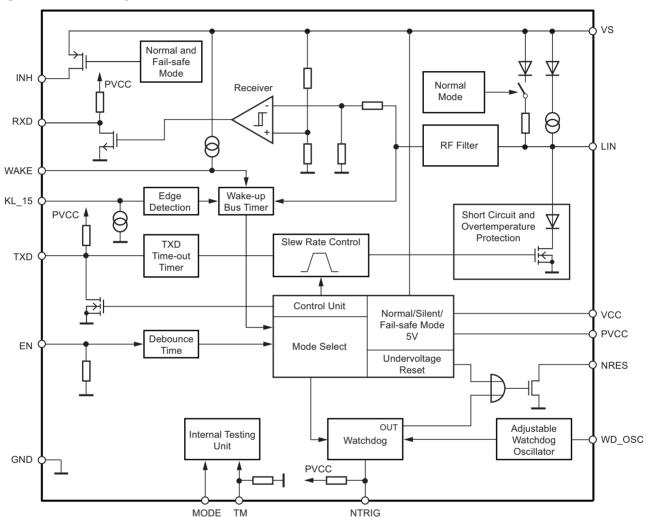
3.1 Features

- Master and slave operation possible
- Supply voltage up to 40V
- Operating voltage V_S = 5V to 27V
- Typically 10µA supply current during sleep mode
- Typically 57µA supply current in silent mode
- Linear low-drop voltage regulator, 85mA current capability:
 - Normal, fail-safe, and silent mode
 - V_{CC} = 5.0V ±2%
 - In sleep mode V_{CC} is switched off
- VCC undervoltage detection (4ms reset time) and watchdog reset logical combined at open drain output NRES
- Negative trigger input for watchdog
- Boosting the voltage regulator possible with an external NPN transistor
- LIN physical layer according to LIN 2.0, 2.1 specification and SAEJ2602-2
- Wake-up capability via LIN-bus, wake pin, or KI_15 pin
- INH output to control an external voltage regulator or to switch off the master pull Up resistor
- TXD time-out timer
- Bus pin is over temperature and short circuit protected versus GND and battery
- Adjustable watchdog time via external resistor
- Advanced EMC and ESD performance
- Fulfills the OEM "hardware requirements for LIN in automotive applications Rev.1.0"
- Interference and damage protection according ISO7637

3.2 Description

The LIN-SBC ATA6624 is a fully integrated LIN transceiver, which complies with the LIN 2.0, 2.1 and SAEJ2602-2 specifications. It has a low-drop voltage regulator for 5V/85mA output and a window watchdog. The voltage regulator is able to source up to 85mA, but the output current can be boosted by using an external NPN transistor.

The LIN-SBC is designed to handle the low-speed data communication in vehicles, e.g., in convenience electronics. Improved slope control at the LIN-driver ensures secure data communication up to 20kBaud. Sleep mode and silent mode guarantee very low current consumption.







3.3 Functional Description

3.3.1 Physical Layer Compatibility

Since the LIN physical layer is independent from higher LIN layers (e.g., the LIN protocol layer), all nodes with a LIN physical layer according to revision 2.x can be mixed with LIN physical layer nodes, which are according to older versions (i.e., LIN 1.0, LIN 1.1, LIN 1.2, LIN 1.3), without any restrictions.

3.3.2 Supply Pin (VS)

The LIN operating voltage is $V_S = 5V$ to 27V. An under voltage detection is implemented to disable data transmission if V_S falls below $VS_{th} < 4V$ in order to avoid false bus messages. After switching on VS, the IC starts in fail-safe mode, and the voltage regulator is switched on (i.e., output capability).

The supply current is typically 10 μ A in sleep mode and 57 μ A in silent mode.

3.3.3 Ground Pin (GND)

The IC does not affect the LIN bus in the event of GND disconnection. It is able to handle a ground shift up to 11.5% of versus The mandatory system ground is pin 5.

3.3.4 Voltage Regulator Output Pin (VCC)

The internal voltage regulator is capable of driving loads with up to 85mA. It is able to supply the microcontroller and other ICs on the PCB and is protected against overloads by means of current limitation and over temperature shut-down. Furthermore, the output voltage is monitored and will cause a reset signal at the NRES output pin if it drops below a defined threshold V_{thun} . To boost up the maximum load current, an external NPN transistor may be used, with its base connected to the VCC pin and its emitter connected to PVCC.

3.3.5 Voltage Regulator Sense Pin (PVCC)

The PVCC is the sense input pin of the voltage regulator. For normal applications (i.e., when only using the internal output transistor), this pin is connected to the VCC pin. If an external boosting transistor is used, the PVCC pin must be connected to the output of this transistor, i.e., its emitter terminal.

3.3.6 Bus Pin (LIN)

A low-side driver with internal current limitation and thermal shutdown and an internal pull-up resistor compliant with the LIN 2.x specification are implemented. The allowed voltage range is between –27V and +40V. Reverse currents from the LIN bus to VS are suppressed, even in the event of GND shifts or battery disconnection. LIN receiver thresholds are compatible with the LIN protocol specification. The fall time from recessive to dominant bus state and the rise time from dominant to recessive bus state are slope controlled.

3.3.7 Input/Output Pin (TXD)

In normal mode the TXD pin is the microcontroller interface used to control the state of the LIN output. TXD must be pulled to ground in order to have a low LIN-bus. If TXD is high or unconnected (internal pull-up resistor), the LIN output transistor is turned off, and the bus is in recessive state. During fail-safe mode, this pin is used as output. It is current-limited to < 8mA. and is latched to low if the last wake-up event was from pin WAKE or KL_15.

3.3.8 TXD Dominant Time-out Function

The TXD input has an internal pull-up resistor. An internal timer prevents the bus line from being driven permanently in dominant state. If TXD is forced to low for longer than $t_{DOM} > 6ms$, the LIN-bus driver is switched to recessive state.

To reactivate the LIN bus driver, switch TXD to high (>10 μ s).

3.3.9 Output Pin (RXD)

The output pin reports the state of the LIN-bus to the microcontroller. LIN high (recessive state) is reported by a high level at RXD; LIN low (dominant state) is reported by a low level at RXD. The output has an internal pull-up resistor with typically $5k\Omega$ to VCC. The AC characteristics can be defined with an external load capacitor of 20pF.

The output is short-circuit protected. RXD is switched off in Unpowered mode (i.e., $V_S = 0V$).



3.3.10 Enable Input Pin (EN)

The enable Input pin controls the operation mode of the device. If EN is high, the circuit is in normal mode, with transmission paths from TXD to LIN and from LIN to RXD both active. The VCC voltage regulator operates with 5V/85mA output capability.

If EN is switched to low while TXD is still high, the device is forced to silent mode. No data transmission is then possible, and the current consumption is reduced to I_{VS} typ. 57µA. The VCC regulator has its full functionality.

If EN is switched to low while TXD is low, the device is forced to sleep mode. No data transmission is possible, and the voltage regulator is switched off.

3.3.11 Wake Input Pin (WAKE)

The wake input pin is a high-voltage input used to wake up the device from sleep mode or silent mode. It is usually connected to an external switch in the application to generate a local wake-up. A pull-up current source, typically 10µA, is implemented.

If a local wake-up is not needed for the application, connect the Wake pin directly to the VS pin.

3.3.12 Mode Input Pin (MODE)

Connect the MODE pin directly or via an external resistor to GND for normal watchdog operation. To debug the software of the connected microcontroller, connect the MODE pin to VCC and the watchdog is switched off.

3.3.13 TM Input Pin

The TM pin is used for final production measurements at Atmel[®]. In normal application, it has to be always connected to GND.

3.3.14 KL_15 Pin

The KL_15 pin is a high-voltage input used to wake up the device from sleep or silent mode. It is an edge sensitive pin (low-to-high transition). It is usually connected to ignition to generate a local wake-up in the application when the ignition is switched on. Although KL_15 pin is at high voltage (V_{Batt}), it is possible to switch the IC into sleep or silent mode. Connect the KL_15 pin directly to GND if you do not need it. A debounce timer with a typical Tdb_{Kl_15} of 160µs is implemented.

The input voltage threshold can be adjusted by varying the external resistor due to the input current $I_{KL_{15}}$. To protect this pin against voltage transients, a serial resistor of $47k\Omega$ and a ceramic capacitor of 100nF are recommended. With this RC combination you can increase the wake-up time $Tw_{KL_{15}}$ and, therefore, the sensitivity against transients on the ignition KI.15.

The wake-up time can also be increased by using external capacitors with higher values.

3.3.15 INH Output Pin

The INH Output pin is used to switch on an external voltage regulator during normal or fail-safe mode. The INH pin is switched off in sleep or silent mode. It is possible to switch off the external $1k\Omega$ master resistor via the INH pin for master node applications. The INH pin is switched off during VCC under voltage reset.

3.3.16 Reset Output Pin (NRES)

The reset output pin, an open drain output, switches to low during V_{CC} under voltage or a watchdog failure.

3.3.17 WD_OSC Output Pin

The WD_OSC output pin provides a typical voltage of 1.2V, which supplies an external resistor with values between $34k\Omega$ and $120k\Omega$ to adjust the watchdog oscillator time.

3.3.18 NTRIG Input Pin

The NTRIG input pin is the trigger input for the window watchdog. A pull-up resistor is implemented. A negative edge triggers the watchdog. The trigger signal (low) must exceed a minimum time $t_{trigmin}$ to generate a watchdog trigger.



3.3.19 Wake-up Events from Sleep or Silent Mode

- LIN-bus
- WAKE pin
- EN pin
- KL_15

3.3.20 Modes of Operation



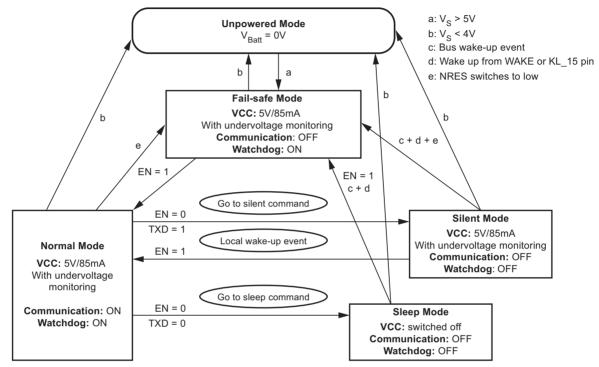


Table 3-1. Table of Modes

Mode of Operation	Transceiver	VCC	Watchdog	WD_OSC	INH	RXD	LIN
Fail-safe	Off	5V	On	1.23V	On	High, except after wake-up	Recessive
Normal	On	5V	On	1.23V	On	LIN depending	TXD depending
Silent	Off	5V	Off	0V	Off	High	Recessive
Sleep	Off	0V	Off	0V	Off	0V	Recessive

3.3.20.1 Normal Mode

This is the normal transmitting and receiving mode at the LIN interface in accordance with the LIN specification LIN 2.x. The voltage regulator is active and can source up to 85mA. The under voltage detection is activated. The watchdog needs a trigger signal from NTRIG to avoid resets at NRES. If NRES is switched to low, the IC changes its state to fail-safe mode.

3.3.20.2 Silent Mode

A falling edge at EN when TXD is high switches the IC into silent mode. The TXD signal has to be logic high during the mode select window (see Figure 3-3). The transmission path is disabled in silent mode. The overall supply current from V_{Batt} is a combination of the I_{VSsi} 57µA plus the VCC regulator output current I_{VCC} .

The internal slave termination between the LIN pin and the VS pin is disabled in silent mode, only a weak pull-up current (typically $10\mu A$) between the LIN pin and the VS pin is present. silent mode can be activated independently from the actual level on the LIN, WAKE, or KL_15 pins.

If an under voltage condition occurs, NRES is switched to low, and the IC changes its state to fail-safe mode.

A voltage lower than the LIN pre_wake detection VLINL at the LIN pin activates the internal LIN receiver and switches on the internal slave termination between the LIN pin and the V_s pin.

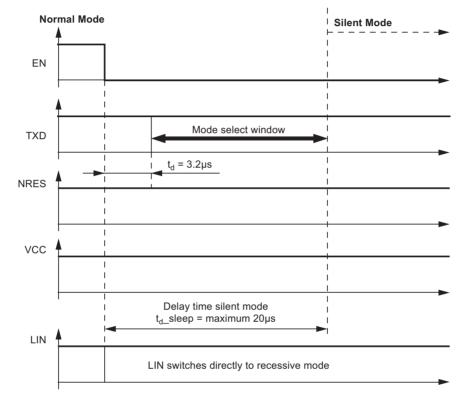
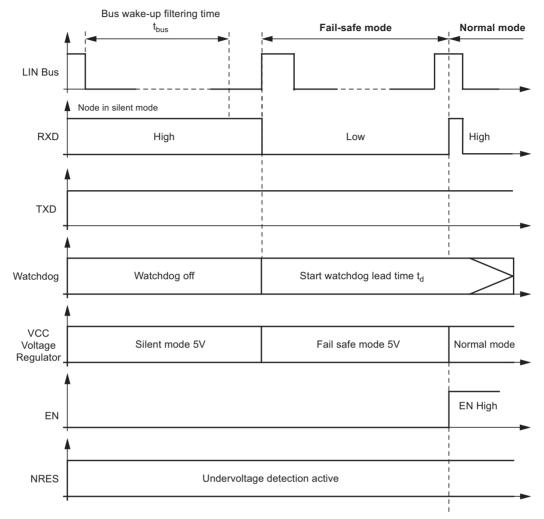


Figure 3-3. Switch to Silent Mode



A falling edge at the LIN pin followed by a dominant bus level maintained for a certain time period (> t_{bus}) and followed by a rising edge at the LIN pin (see Figure 3-4) result in a remote wake-up request. The device switches from silent mode to fail-safe mode. The remote wake-up request is indicated by a low level at the RXD pin to interrupt the microcontroller (see Figure 3-4). EN high can be used to switch directly to normal mode.





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3.3.20.3 Sleep Mode

A falling edge at EN when TXD is low switches the IC into sleep mode. The TXD signal has to be logic low during the mode select window (Figure 3-5). In order to avoid any influence to the LIN-pin during switching into sleep mode it is possible to switch the EN up to 3.2 μ s earlier to LOW than the TXD. Therefore, the best and easiest way are two falling edges at TXD and EN at the same time. The transmission path is disabled in sleep mode. The supply current I_{VSsleep} from V_{Batt} is typically 10 μ A.

The VCC regulator and the INH output are switched off. NRES and RXD are low. The internal slave termination between the LIN pin and VS pin is disabled, only a weak pull-up current (typically 10µA) between the LIN pin and the VS pin is present. sleep mode can be activated independently from the current level on the LIN, WAKE, or KL_15 pin.

A voltage lower than the LIN pre_wake detection VLINL at the LIN pin activates the internal LIN receiver and switches on the internal slave termination between the LIN pin and the V_8 pin.

A falling edge at the LIN pin followed by a dominant bus level maintained for a certain time period (> t_{bus}) and followed by a rising edge at pin LIN results in a remote wake-up request. The device switches from sleep mode to fail-safe mode.

The VCC regulator is activated, and the remote wake-up request is indicated by a low level at the RXD pin to interrupt the microcontroller (see Figure 3-6 on page 15).

EN high can be used to switch directly from sleep/silent to fail-safe mode. If EN is still high after VCC ramp up and under voltage reset time, the IC switches to the normal mode.

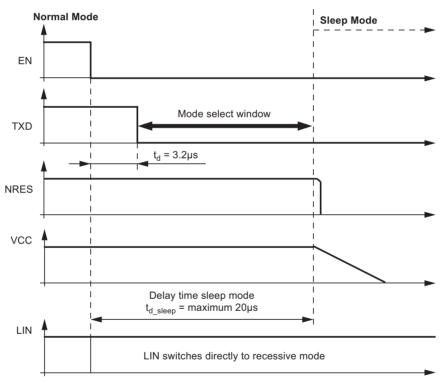


Figure 3-5. Switch to Sleep Mode

3.3.20.4 Fail-safe Mode

The device automatically switches to fail-safe mode at system power-up and the voltage regulator is switched on (see Figure 3-7 on page 17). The NRES output switches to low for t_{res} = 4ms and gives a reset to the microcontroller. LIN communication is switched off. The IC stays in this mode until EN is switched to high. The IC then changes to normal mode. A power down of V_{Batt} (V_S < 4V) during silent or sleep mode switches the IC into fail-safe mode. A low at NRES switches into fail-safe mode directly. During fail-safe mode the TXD pin is an output and signals the last wake-up source.

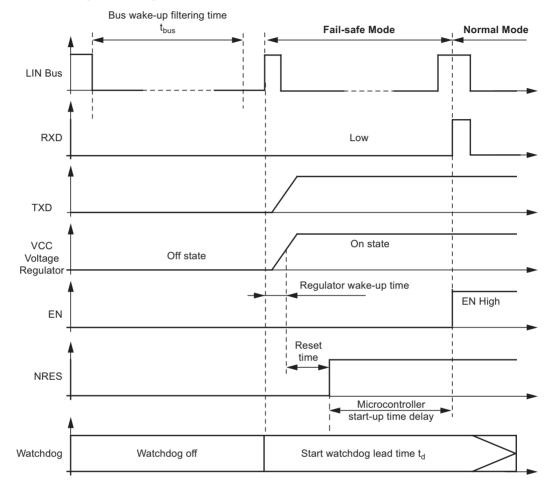
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3.3.20.5 Unpowered Mode

If you connect battery voltage to the application circuit, the voltage at the VS pin increases according to the block capacitor (see Figure 3-7 on page 17). After VS is higher than the VS undervoltage threshold VS_{th}, the IC mode changes from unpowered mode to fail-safe mode. The VCC output voltage reaches its nominal value after t_{VCC} . This time, t_{VCC} , depends on the VCC capacitor and the load.

The NRES is low for the reset time delay t_{reset} . During this time, t_{reset} , no mode change is possible.





3.3.21 Wake-up Scenarios from Silent to Sleep Mode

3.3.21.1 Remote Wake-up via Dominant Bus State

A voltage lower than the LIN pre_wake detection V_{LINL} at the LIN pin activates the internal LIN receiver.

A falling edge at the LIN pin followed by a dominant bus level V_{BUSdom} maintained for a certain time period (> t_{BUS}) and followed by a rising edge at pin LIN result in a remote wake-up request. The device switches from silent or sleep mode to fail-safe mode. The VCC voltage regulator is/remains activated, the INH pin is switched to high, and remote wake-up request is indicated by a low level at the RXD pin to generate an interrupt for the microcontroller. A low level at the LIN pin in the normal mode starts the bus wake-up filtering time, and if the IC is switched to silent or sleep mode, it will receive a wake-up after a positive edge at the LIN pin.



3.3.21.2 Local Wake-up via Pin Wake

A falling edge at the WAKE pin followed by a low level maintained for a certain time period (> t_{WAKE}) results in a local wake-up request. The device switches to fail-safe mode. The local wake-up request is indicated by a low level at the RXD pin to generate an interrupt in the microcontroller and a strong pull down at TXD. When the wake pin is low, it is possible to switch to silent or sleep mode via pin EN. In this case, the wake-up signal has to be switched to high >10µs before the negative edge at WAKE starts a new local wake-up request.

3.3.21.3 Local Wake-up via Pin KL_15

A positive edge at pin KL_15 followed by a high voltage level for a certain time period ($t_{KL_{15}}$) results in a local wake-up request. The device switches into the fail-safe mode. The extra long wake-up time ensures that no transients at KL_15 create a wake up. The local wake-up request is indicated by a low level at the RXD pin to generate an interrupt for the microcontroller and a strong pull down at TXD. During high-level voltage at pin KL_15, it is possible to switch to silent or sleep mode via pin EN. In this case, the wake-up signal has to be switched to low >250µs before the positive edge at KL_15 starts a new local wake-up request. With external RC combination, the time is even longer.

3.3.21.4 Wake-up Source Recognition

The device can distinguish between a local wake-up request (Wake or KL_15 pins) and a remote wake-up request (via LIN bus). The wake-up source can be read on the TXD pin in fail-safe mode. A high level indicates a remote wake-up request (weak pull up at the TXD pin); a low level indicates a local wake-up request (strong pull down at the TXD pin). The wake-up request flag (signalled on the RXD pin), as well as the wake-up source flag (signalled on the TXD pin), is immediately reset if the microcontroller sets the EN pin to high (see Figure 3-3 on page 12 and Figure 3-4 on page 13) and the IC is in normal mode. The last wake-up source flag is stored and signalled in fail-safe mode at the TXD pin.

3.3.22 Fail-safe Features

- During a short-circuit at LIN to V_{Battery}, the output limits the output current to I_{BUS_LIM}. Due to the power dissipation, the chip temperature exceeds T_{LINoff}, and the LIN output is switched off. The chip cools down and after a hysteresis of T_{hys}, switches the output on again. RXD stays on high because LIN is high. During LIN over temperature switch-off, the VCC regulator works independently.
- During a short-circuit from LIN to GND the IC can be switched into sleep or silent mode. If the short-circuit disappears, the IC starts with a remote wake-up.
- The reverse current is very low <15µA at the LIN pin during loss of V_{Batt} or GND. This is optimal behavior for bus systems where some slave nodes are supplied from battery or ignition.
- During a short circuit at VCC, the output limits the output current to I_{VCCn}. Because of under voltage, NRES switches to low and sends a reset to the microcontroller. The IC switches into fail-safe mode. If the chip temperature exceeds the value T_{VCCoff}, the VCC output switches off. The chip cools down and after a hysteresis of T_{hys}, switches the output on again. Because of the fail-safe mode, the VCC voltage will switch on again although EN is switched off from the microcontroller. The microcontroller can start with its normal operation.
- EN pin provides a pull-down resistor to force the transceiver into recessive mode if EN is disconnected.
- RXD pin is set floating if V_{Batt} is disconnected.
- TXD pin provides a pull-up resistor to force the transceiver into recessive mode if TXD is disconnected.
- If TXD is short-circuited to GND, it is possible to switch to sleep mode via ENABLE after t_{dom} >20ms.
- If the WD_OSC pin has a short-circuit to GND and the NTRIG signal has a period time >27ms, the watchdog runs with an internal oscillator and guarantees a reset after the second NTRIG signal at the latest.
- If the resistor at WO_OSC pin is disconnected, the watchdog runs with an internal oscillator and guarantees a reset after the second NTRIG signal at the latest.



3.3.23 Voltage Regulator

The voltage regulator needs an external capacitor for compensation and for smoothing the disturbances from the microcontroller. It is recommended to use an electrolytic capacitor with $C \ge 1.8 \mu$ F and a ceramic capacitor with C = 100nF. The values of these capacitors can be varied by the customer, depending on the application.

The main power dissipation of the IC is created from the VCC output current I_{VCC} , which is needed for the application. In Figure 3-8 the safe operating area is shown.

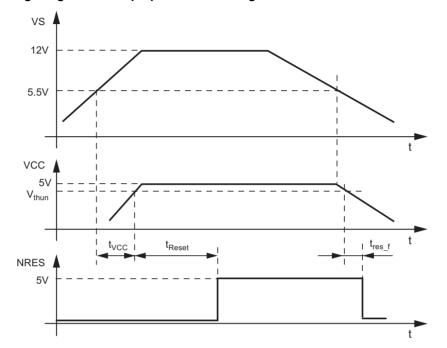
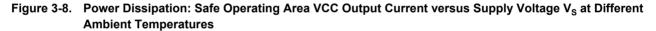
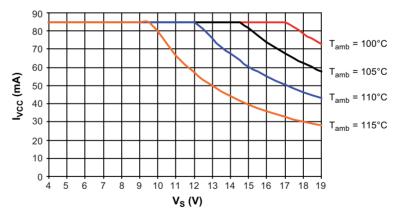


Figure 3-7. VCC Voltage Regulator: Ramp Up and Undervoltage Detection





For programming purposes of the microcontroller it is potentially necessary to supply the V_{CC} output via an external power supply while the V_S pin of the system basis chip is disconnected. This will not affect the system basis chip.

3.3.24 Watchdog

The watchdog anticipates a trigger signal from the microcontroller at the NTRIG (negative edge) input within a time window of T_{wd} . The trigger signal must exceed a minimum time $t_{trigmin} > 200$ ns. If a triggering signal is not received, a reset signal will be generated at output NRES. After a watchdog reset the IC starts with the lead time. The timing basis of the watchdog is provided by the internal oscillator. Its time period, T_{osc} , is adjustable via the external resistor $R_{wd osc}$ (34k Ω to 120k Ω).

During silent or sleep mode the watchdog is switched off to reduce current consumption.

The minimum time for the first watchdog pulse is required after the under voltage reset at NRES disappears. It is defined as lead time t_d . After wake up from sleep or silent mode, the lead time t_d starts with the negative edge of the RXD output.

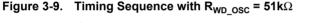
3.3.24.1 Typical Timing Sequence with $R_{WD OSC} = 51 k \Omega$

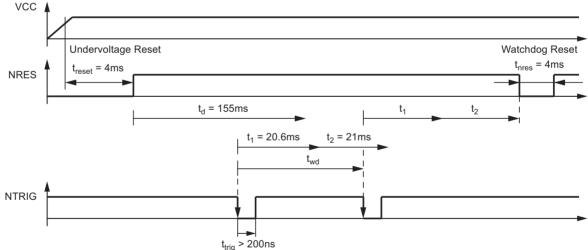
The trigger signal T_{wd} is adjustable between 20ms and 64ms using the external resistor $R_{WD OSC}$.

For example, with an external resistor of $R_{WD_{OSC}} = 51 k\Omega \pm 1\%$, the typical parameters of the watchdog are as follows:

$$\begin{split} t_{osc} &= 0.405 \times R_{WD_OSC} - 0.0004 \times (R_{WD_OSC})^2 \, (R_{WD_OSC} \text{ in } k\Omega; \, t_{osc} \text{ in } \mu s) \\ t_{OSC} &= 19.6 \mu s \text{ due to } 51 k\Omega \\ t_d &= 7895 \times 19.6 \mu s = 155 \text{ms} \\ t_1 &= 1053 \times 19.6 \mu s = 20.6 \text{ms} \\ t_2 &= 1105 \times 19.6 \mu s = 21.6 \text{ms} \\ t_{nres} &= \text{constant} = 4 \text{ms} \end{split}$$

After ramping up the battery voltage, the 5V regulator is switched on. The reset output NRES stays low for the time t_{reset} (typically 4ms), then it switches to high, and the watchdog waits for the trigger sequence from the microcontroller. The lead time, t_d , follows the reset and is $t_d = 155$ ms. In this time, the first watchdog pulse from the microcontroller is required. If the trigger pulse NTRIG occurs during this time, the time t_1 starts immediately. If no trigger signal occurs during the time t_d , a watchdog reset with $t_{NRES} = 4$ ms will reset the microcontroller after $t_d = 155$ ms. The times t_1 and t_2 have a fixed relationship between each other. A triggering signal from the microcontroller is anticipated within the time frame of $t_2 = 21.6$ ms. To avoid false triggering from glitches, the trigger pulse must be longer than $t_{TRIG,min} > 200$ ns. This slope serves to restart the watchdog sequence. If the triggering signal fails in this open window t_2 , the NRES output will be drawn to ground. A triggering signal during the closed window t_1 immediately switches NRES to low.







3.3.24.2 Worst Case Calculation with R_{WO_OSC} = 51k Ω

The internal oscillator has a tolerance of 20%. This means that t_1 and t_2 can also vary by 20%. The worst case calculation for the watchdog period t_{wd} is calculated as follows.

The ideal watchdog time t_{wd} is between the maximum t_1 and the minimum t_1 plus the minimum t_2 .

 $\begin{array}{l} t_{1,\text{min}} = 0.8 \times t_1 = 16.5\text{ms}, \ t_{1,\text{max}} = 1.2 \times t_1 = 24.8\text{ms} \\ t_{2,\text{min}} = 0.8 \times t_2 = 17.3\text{ms}, \ t_{2,\text{max}} = 1.2 \times t_2 = 26\text{ms} \\ t_{\text{wdmax}} = t_{1\text{min}} + t_{2\text{min}} = 16.5\text{ms} + 17.3\text{ms} = 33.8\text{ms} \\ t_{\text{wdmin}} = t_{1\text{max}} = 24.8\text{ms} \\ t_{\text{wd}} = 29.3\text{ms} \pm 4.5\text{ms} \ (\pm 15\%) \end{array}$

A microcontroller with an oscillator tolerance of ±15% is sufficient to supply the trigger inputs correctly.

R _{wd_osc} kΩ	Oscillator Period t _{osc} /µs	Lead Time t _d /ms	Closed Window t ₁ /ms	Open Window t ₂ /ms	Trigger Period from Microcontroller t _{wd} /ms	Reset Time t _{nres} /ms
34	13.3	105	14.0	14.7	19.9	4
51	19.61	154.8	20.64	21.67	29.32	4
91	33.54	264.80	35.32	37.06	50.14	4
120	42.84	338.22	45.11	47.34	64.05	4

Table 3-2. Typical Watchdog Timings



4. Electrical Characteristics

 $5V < V_S < 27V$, $-40^{\circ}C < T_{case} < 125^{\circ}C$, $-40^{\circ}C < T_j < 150^{\circ}C$, unless otherwise specified. All values refer to GND pins

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
1	VS Pin								
1.1	Nominal DC voltage range		VS	Vs	5		27	V	А
1.2	Supply current in sleep	Sleep mode $V_{LIN} > V_S - 0.5V$ $V_S < 14V (T_j = 25^{\circ}C)$	VS	I _{VSsleep}	3	10	14	μA	В
1.2	mode	Sleep mode $V_{LIN} > V_S - 0.5V$ $V_S < 14V (T_j = 125^{\circ}C)$	VS	I _{VSsleep}	5	11	16	μA	A
1.3	Supply current in silent	Bus recessive V _S < 14V (T _j = 25°C) Without load at VCC	VS	I _{VSsi}	47	57	67	μA	В
1.5	mode	Bus recessive V _S < 14V (T _j = 125°C) Without load at VCC	VS	I _{VSsi}	56	66	76	μA	A
1.4	Supply current in normal mode	Bus recessive V _S < 14V Without load at VCC	VS	I _{VSrec}	0.3		0.8	mA	A
1.5	Supply current in normal mode	Bus dominant V _S < 14V V _{CC} load current 50mA	VS	I _{VSdom}	50		53	mA	A
1.6	Supply current in fail-safe mode	Bus recessive V _S < 14V Without load at VCC	VS	I _{VSfail}	250		550	μA	A
1.7	V _s undervoltage threshold		VS	V _{Sth}	3.7	4.4	5	V	A
1.8	VS undervoltage threshold hysteresis		VS	V _{Sth_hys}		0.2		V	А
2	RXD Output Pin								
2.1	Low-level output sink current	Normal mode $V_{LIN} = 0V$ $V_{RXD} = 0.4V$	RXD	I _{RXD}	1.3	2.5	8	mA	A
2.2	Low-level output voltage	I _{RXD} = 1mA	RXD	V _{RXDL}			0.4	V	Α
2.3	Internal resistor to V_{CC}		RXD	R _{RXD}	3	5	7	kΩ	Α
3	TXD Input/Output Pin								
3.1	Low-level voltage input		TXD	V _{TXDL}	-0.3		+0.8	V	Α
3.2	High-level voltage input		TXD	V _{TXDH}	2		V _{CC} + 0.3V	V	A
3.3	Pull-up resistor	V _{TXD} = 0V	TXD	R _{TXD}	125	250	400	kΩ	Α
3.4	High-level leakage current	V _{TXD} = VCC	TXD	I _{TXD}	-3		+3	μA	A
3.5	Low-level output sink current at local wake-up request	Fail-safe mode $V_{LIN} = V_S$ $V_{WAKE} = 0V$ $V_{TXD} = 0.4V$	TXD	I _{TXDwake}	2	2.5	8	mA	A

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

 $5V < V_S < 27V$, $-40^{\circ}C < T_{case} < 125^{\circ}C$, $-40^{\circ}C < T_j < 150^{\circ}C$, unless otherwise specified. All values refer to GND pins

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type
4	EN Input Pin								
4.1	Low-level voltage input		EN	V _{ENL}	-0.3		+0.8	V	Α
4.2	High-level voltage input		EN	V _{ENH}	2		V _{CC} + 0.3V	V	A
4.3	Pull-down resistor	$V_{EN} = V_{CC}$	EN	R _{EN}	50	125	200	kΩ	Α
4.4	Low-level input current	V _{EN} = 0V	EN	I _{EN}	-3		+3	μA	Α
5	NTRIG Watchdog Input I	Pin							
5.1	Low-level voltage input		NTRIG	V _{NTRIGL}	-0.3		+0.8	V	A
5.2	High-level voltage input		NTRIG	V _{NTRIGH}	2		V _{CC} + 0.3V	V	A
5.3	Pull-up resistor	V _{NTRIG} = 0V	NTRIG	R _{NTRIG}	125	250	400	kΩ	Α
5.4	High-level leakage current	$V_{\rm NTRIG} = V_{\rm CC}$	NTRIG	I _{NTRIG}	-3		+3	μA	A
6	Mode Input Pin	1	1	ł			1		
6.1	Low-level voltage input		MODE	V _{MODEL}	-0.3		+0.8	V	Α
6.2	High-level voltage input		MODE	V _{MODEH}	2		V _{CC} + 0.3V	V	A
6.3	High-level leakage current	$V_{MODE} = V_{CC} \text{ or}$ $V_{MODE} = 0V$	MODE	I _{MODE}	-3		+3	μA	A
7	INH Output Pin			1	I		1	 	
7.1	High-level voltage	I _{INH} = –15mA	INH	V _{INHH}	V _S – 0.75		Vs	V	Α
7.2	Switch-on resistance between VS and INH		INH	R _{INH}		30	50	Ω	A
7.3	Leakage current	Sleep mode V _{INH} = 0V/27V, V _S = 27V	INH	I _{INHL}	-3		+3	μA	A
8	Load 3 (medium): 6.8nF,	d Conditions: ;; Load 2 (large): 10nF, 500Ω 660Ω, characterized on san he timing parameters for pro	nples					:/s	
8.1	Driver recessive output voltage	Load1/load2	LIN	V _{BUSrec}	$0.9 imes V_S$		Vs	V	А
8.2	Driver dominant voltage	$V_{VS} = 7V$ $R_{load} = 500\Omega$	LIN	V_LoSUP			1.2	V	A
8.3	Driver dominant voltage	$V_{VS} = 18V$ $R_{load} = 500\Omega$	LIN	V_ _{HISUP}			2	V	Α
8.4	Driver dominant voltage	$V_{VS} = 7.0V$ R _{load} = 1000 Ω	LIN	V_LoSUP_1k	0.6			V	A
8.5	Driver dominant voltage	$V_{VS} = 18V$ R _{load} = 1000 Ω	LIN	V_HISUP_1k	0.8			V	A
8.6	Pull-up resistor to V_S	The serial diode is mandatory	LIN	R _{LIN}	20	30	60	kΩ	A

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

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No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
8.8	LIN current limitation $V_{BUS} = V_{Batt_max}$		LIN	I _{BUS_LIM}	40	120	200	mA	Α
8.9	Input leakage current at the receiver including pull-up resistor as specified	Input leakage current Driver off $V_{BUS} = 0V$ $V_{Batt} = 12V$	LIN	I _{BUS_PAS_do} m	-1	-0.35		mA	A
8.10	Leakage current LIN recessive	Driver off $8V < V_{Batt} < 18V$ $8V < V_{BUS} < 18V$ $V_{BUS} \ge V_{Batt}$	LIN	I _{BUS_PAS_re} c		10	20	μΑ	A
8.11	Leakage current when control unit disconnected from ground. Loss of local ground must not affect communication in the residual network.	$GND_{Device} = V_S$ $V_{Batt} = 12V$ $0V < V_{BUS} < 18V$	LIN	I _{BUS_NO_gn} d	-10	+0.5	+10	μΑ	A
8.12	Leakage current at a disconnected battery. Node has to sustain the current that can flow under this condition. Bus must remain operational under this condition.	V_{Batt} disconnected $V_{SUP_Device} = GND$ $0V < V_{BUS} < 18V$	LIN	I _{BUS_NO_bat}		0.1	2	μΑ	A
9	LIN Bus Receiver								
9.1	Center of receiver threshold	V _{BUS_CNT} = (V _{th_dom} + V _{th_rec})/2	LIN	V _{BUS_CNT}	$0.475 \times V_{S}$	$0.5 \times V_S$	$0.525 \times V_{S}$	V	А
9.2	Receiver dominant state	V _{EN} = 5V	LIN	V _{BUSdom}			$0.4 imes V_S$	V	Α
9.3	Receiver recessive state	V _{EN} = 5V	LIN	V _{BUSrec}	$0.6 imes V_S$			V	Α
9.4	Receiver input hysteresis	$V_{hys} = V_{th_rec} - V_{th_dom}$	LIN	V _{BUShys}	$\begin{array}{c} 0.028 \times \\ V_{S} \end{array}$	$0.1 \times V_S$	$0.175 \times V_{S}$	V	А
9.5	Pre_Wake detection LIN High-level input voltage		LIN	V _{LINH}	$V_{\rm S} - 2V$		V _S + 0.3V	V	А
9.6	Pre_Wake detection LIN Low-level input voltage	Activates the LIN receiver	LIN	V _{LINL}	-27		V _S – 3.3V	V	Α

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

 $5V < V_S < 27V$, $-40^{\circ}C < T_{case} < 125^{\circ}C$, $-40^{\circ}C < T_j < 150^{\circ}C$, unless otherwise specified. All values refer to GND pins

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
10	Internal Timers								
10.1	Dominant time for wake- up via LIN bus	V _{LIN} = 0V	LIN	t _{bus}	30	90	150	μs	Α
10.2	Time delay for mode change from fail-safe into normal mode via EN pin	V _{EN} = 5V	EN	t _{norm}	5	15	20	μs	A
10.3	Time delay for mode change from normal mode to sleep mode via EN pin	V _{EN} = 0V	EN	t _{sleep}	2	7	12	μs	A
10.4	TXD dominant time-out time	V _{TXD} = 0V	TXD	t _{dom}	6	13	20	ms	Α
10.5	Time delay for mode change from silent mode into normal mode via EN	V _{EN} = 5V	EN	t _{s_n}	5	15	40	μs	A
10.6	Duty cycle 1	$\begin{array}{l} TH_{Rec(max)} = 0.744 \times V_S \\ TH_{Dom(max)} = 0.581 \times V_S \\ V_S = 7.0V \ to \ 18V \\ t_{Bit} = 50 \mu s \\ D1 = t_{bus_rec(min)}/(2 \times t_{Bit}) \end{array}$	LIN	D1	0.396				A
10.7	Duty cycle 2	$\begin{array}{l} TH_{Rec(min)} = 0.422 \times V_{S} \\ TH_{Dom(min)} = 0.284 \times V_{S} \\ V_{S} = 7.6 V \text{ to } 18 V \\ t_{Bit} = 50 \mu s \\ D2 = t_{bus_rec(max)} / (2 \times t_{Bit}) \end{array}$	LIN	D2			0.581		A
10.8	Duty cycle 3	$\begin{array}{l} TH_{Rec(max)} = 0.778 \times V_S \\ TH_{Dom(max)} = 0.616 \times V_S \\ V_S = 7.0V \ to \ 18V \\ t_{Bit} = 96 \mu s \\ D3 = t_{bus_rec(min)}/(2 \times t_{Bit}) \end{array}$	LIN	D3	0.417				A
10.9	Duty cycle 4	$\begin{array}{l} \text{TH}_{\text{Rec}(\text{min})} = 0.389 \times \text{V}_{\text{S}} \\ \text{TH}_{\text{Dom}(\text{min})} = 0.251 \times \text{V}_{\text{S}} \\ \text{V}_{\text{S}} = 7.6 \text{V} \text{ to } 18 \text{V} \\ \text{t}_{\text{Bit}} = 96 \mu \text{s} \\ \text{D4} = t_{\text{bus}_\text{rec}(\text{max})} / (2 \times t_{\text{Bit}}) \end{array}$	LIN	D4			0.590		A
10.10	Slope time falling and rising edge at LIN	V _S = 7.0V to 18V	LIN	t _{SLOPE_fall} t _{SLOPE_rise}	3.5		22.5	μs	А
11		arameters of the LIN Physic Conditions (CRXD): 20pF	al Layer						
11.1	Propagation delay of receiver (Figure 4-1 on page 26)	V_{s} = 7.0V to 18V t_{rx_pd} = max(t_{rx_pdr} , t_{rx_pdf})	RXD	t _{rx_pd}			6	μs	A
11.2	Symmetry of receiver propagation delay rising edge minus falling edge	V_{s} = 7.0V to 18V t_{rx_sym} = $t_{rx_pdr} - t_{rx_pdf}$	RXD	t _{rx_sym}	-2		+2	μs	A

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

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 $5V < V_S < 27V$, $-40^{\circ}C < T_{case} < 125^{\circ}C$, $-40^{\circ}C < T_j < 150^{\circ}C$, unless otherwise specified. All values refer to GND pins

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
12	NRES Open Drain Outpu	ut Pin							
12.1	Low-level output voltage	V _S ≥ 5.5V I _{NRES} = 1mA	NRES	V _{NRESL}			0.14	V	А
12.2	Low-level output low	$\begin{array}{l} 10 k\Omega \text{ to } 5 \text{V} \\ \text{V}_{\text{CC}} = 0 \text{V} \end{array}$	NRES	V _{NRESLL}			0.14	V	А
12.3	Undervoltage reset time	V _S ≥ 5.5V C _{NRES} = 20pF	NRES	t _{reset}	2	4	6	ms	А
12.4	Reset debounce time for falling edge	V _S ≥ 5.5V C _{NRES} = 20pF	NRES	t _{res_f}	1.5		10	μs	А
13	Watchdog Oscillator								
13.1	Voltage at WD_OSC in normal mode	I _{WD_OSC} = −200μA V _{VS} ≥ 4V	WD_OSC	V _{WD_OSC}	1.13	1.23	1.33	V	А
13.2	Possible values of resistor		WD_OSC	R _{osc}	34		120	kΩ	А
13.3	Oscillator period	$R_{OSC} = 34k\Omega$		tosc	10.65	13.3	15.97	μs	Α
13.4	Oscillator period	R _{OSC} = 51kΩ		t _{osc}	15.68	19.6	23.52	μs	Α
13.5	Oscillator period	$R_{OSC} = 91k\Omega$		t _{osc}	26.83	33.5	40.24	μs	Α
13.6	Oscillator period	R _{OSC} = 120kΩ		t _{osc}	34.2	42.8	51.4	μs	Α
14	Watchdog Timing Relativ	ve to t _{OSC}	11					.1	
14.1	Watchdog lead time after reset			t _d		7895		cycles	А
14.2	Watchdog closed window			t ₁		1053		cycles	А
14.3	Watchdog open window			t ₂		1105		cycles	Α
14.4	Watchdog reset time NRES		NRES	t _{nres}	3.2	4	4.8	ms	А
15	KL_15 Pin							1	
15.1	High-level input voltage R_V = 47 k Ω	Positive edge initializes a wake-up	KL_15	$V_{KL_{15H}}$	4		V _S + 0.3V	V	А
15.2	Low-level input voltage R_V = 47 k Ω		KL_15	V _{KL_15L}	-1		+2	V	А
15.3	KL_15 pull-down current	V _S < 27V V _{KL_15} = 27V	KL_15	I _{KL_15}		50	65	μA	А
15.4	Internal debounce time	Without external capacitor	KL_15	Tdb _{KL_15}	80	160	250	μs	Α
15.5	KL_15 wake-up time	$R_V = 47k\Omega$, C = 100nF	KL_15	Tw _{KL_15}	0.4	2	4.5	ms	С
16	WAKE Pin								
16.1	High-level input voltage		WAKE	V _{WAKEH}	V _S – 1V		V _S + 0.3V	V	А
16.2	Low-level input voltage	Initializes a wake-up signal	WAKE	V _{WAKEL}	-1		V _S – 3.3V	V	А
16.3	WAKE pull-up current	V _S < 27V V _{WAKE} = 0V	WAKE	I _{WAKE}	-30	-10		μA	А
16.4	High-level leakage current	V _S = 27V V _{WAKE} = 27V	WAKE	I _{WAKEL}	-5		+5	μA	А

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter



$5V < V_S < 27V$, $-40^{\circ}C < T_c$	_{ase} < 125°C,	, unless otherwise specified. All values refer to GND pins
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No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
16.5	Time of low pulse for wake-up via WAKE pin	V _{WAKE} = 0V	WAKE	I _{WAKEL}	30	70	150	μs	A
17	VCC Voltage Regulator,	PVCC = VCC							
17.1	Output voltage VCC	5.5V < V _S < 18V (0mA to 50mA)	VCC	VCC _{nor}	4.9		5.1	V	A
17.1	Output voltage voo	6V < V _S < 18V (0mA to 85mA)	VCC	VCC _{nor}	4.9		5.1	V	С
17.2	Output voltage VCC at low VS	4V < V _S < 5.5V	VCC	VCC _{low}	$V_{\rm S} - V_{\rm D}$		5.1	V	А
17.3	Regulator drop voltage	$V_{\rm S}$ > 4V $I_{\rm VCC}$ = -20mA	VS, VCC	V _{D1}			250	mV	A
17.4	Regulator drop voltage	$V_{\rm S}$ > 4V $I_{\rm VCC}$ = -50mA	VS, VCC	V _{D2}		400	600	mV	A
17.5	Regulator drop voltage	V _S > 3.3V I _{VCC} = -15mA	VS, VCC	V_{D3}			200	mV	A
17.6	Line regulation	5.5V < V _S < 18V	VCC	VCC _{line}		0.1	0.2	%	Α
17.7	Load regulation	5mA < I _{VCC} < 50mA	VCC	VCC _{load}		0.1	0.5	%	Α
17.8	Power supply ripple rejection	10Hz to 100kHz $C_{VCC} = 10\mu F$ $V_S = 14V, I_{VCC} = -15mA$	VCC		50			dB	D
17.9	Output current limitation	V _S > 5.5V	VCC	I _{VCClim}	-240	-130	-85	mA	Α
17.10	External load capacity	$0.2\Omega < \text{ESR} < 5\Omega \text{ at}$ 100kHz for phase margin $\ge 60^\circ$ ESR < 0.2Ω at 100kHz	VCC	C _{load}	1.8	10		μF	D
		$ESR < 0.2\Omega$ at 100kHz for phase margin $\ge 30^{\circ}$							
17.11	VCC undervoltage threshold	Referred to VCC $V_{\rm S}$ > 5.5V	VCC	V _{thunN}	4.2		4.8	V	А
17.12	Hysteresis of undervoltage threshold	Referred to VCC $V_S > 5.5V$	VCC	Vhys _{thun}		250		mV	А
17.13	Ramp-up time $V_S > 5.5V$ to $V_{CC} = 5V$	C_{VCC} = 2.2µF I _{load} = -5mA at VCC	VCC	t _{VCC}		130	300	μs	A

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter